# MOSFET – Power, N-Channel, SUPERFET<sup>®</sup> III, FRFET<sup>®</sup> 650 V, 65 A, 40 m $\Omega$

# NTHLD040N65S3HF

# **Description**

SUPERFET III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate.

Consequently, SUPERFET III MOSFET is very suitable for the various power system for miniaturization and higher efficiency.

SUPERFET III FRFET MOSFET's optimized reverse recovery performance of body diode can remove additional component and improve system reliability.

#### **Features**

- 700 V @  $T_J = 150$ °C
- Typ.  $R_{DS(on)} = 32 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 159 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 1367 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

### **Applications**

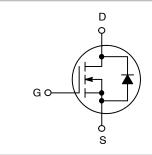
- Telecom / Server Power Supplies
- Industrial Power Supplies
- EV Charger
- UPS / Solar

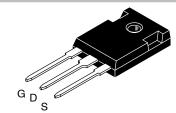


# ON Semiconductor®

#### www.onsemi.com

| V <sub>DSS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |
|------------------|-------------------------|--------------------|
| 650 V            | 40 mΩ @ 10 V            | 65 A               |





TO-247AD CASE 340AL

#### **MARKING DIAGRAM**



A = Assembly Location

Y = Year WW = Work Week

G = Pb-Free Package

### ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

# **ABSOLUTE MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ , Unless otherwise noted)

| Symbol                            | Parameter  | Value                                 | Unit        |      |
|-----------------------------------|--|---------------------------------------|-------------|------|
| $V_{DSS}$                         | Drain to Source Voltage  |                                       | 650         | V    |
| $V_{GSS}$                         | Gate to Source Voltage   | - DC                                  | ±30         | V    |
|                                   |  | – AC (f > 1 Hz)                       | ±30         |      |
| I <sub>D</sub>                    | Drain Current  | – Continuous (T <sub>C</sub> = 25°C)  | 65          | Α    |
|                                   |  | - Continuous (T <sub>C</sub> = 100°C) | 45          |      |
| I <sub>DM</sub>                   | Drain Current  | - Pulsed (Note 1)                     | 162.5       | Α    |
| E <sub>AS</sub>                   | Single Pulsed Avalanche Energy (Note 2)                              |                                       | 1009        | mJ   |
| I <sub>AS</sub>                   | Avalanche Current (Note 2)   |                                       | 9           | Α    |
| E <sub>AR</sub>                   | Repetitive Avalanche Energy (Note 1)                                 |                                       | 4.46        | mJ   |
| dv/dt                             | MOSFET dv/dt   |                                       | 100         | V/ns |
|                                   | Peak Diode Recovery dv/dt (Note 3)                                   | 50                                    |             |      |
| $P_{D}$                           | Power Dissipation  | (T <sub>C</sub> = 25°C)               | 446         | W    |
|                                   |  | - Derate Above 25°C                   | 3.57        | W/°C |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Temperature Range                              |                                       | -55 to +150 | °C   |
| TL                                | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds |                                       | 300         | °C   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 
1. Repetitive rating: pulse–width limited by maximum junction temperature. 
2.  $I_{AS} = 9 \text{ A}$ ,  $R_G = 25 \Omega$ , starting  $T_J = 25^{\circ}\text{C}$ . 
3.  $I_{SD} \le 32.5 \text{ A}$ ,  $di/dt \le 200 \text{ A}/\mu\text{s}$ ,  $V_{DD} \le 400 \text{ V}$ , starting  $T_J = 25^{\circ}\text{C}$ .

### THERMAL CHARACTERISTICS

| Symbol         | Parameter                                     | Value | Unit |
|----------------|---|-------|------|
| $R_{	heta JC}$ | Thermal Resistance, Junction to Case, Max.    | 0.28  | °C/W |
| $R_{	heta JA}$ | Thermal Resistance, Junction to Ambient, Max. | 40    |      |

# PACKAGE MARKING AND ORDERING INFORMATION

| I | Part Number     | Top Marking     | Package | Packing Method | Reel Size | Tape Width | Quantity |
|---|-----------------|-----------------|---------|----------------|-----------|------------|----------|
|   | NTHLD040N65S3HF | NTHLD040N65S3HF | TO-247  | Tube           | N/A       | N/A        | 30 Units |

# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

| Symbol                         | Parameter                                    | Test Conditions  | Min. | Тур. | Max.  | Unit |
|--------------------------------|--|--|------|------|-------|------|
| OFF CHARACT                    | ERISTICS                                     |  |      |      |       |      |
| BV <sub>DSS</sub>              | Drain to Source Breakdown Voltage            | $V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}, T_J = 25^{\circ}\text{C}$     | 650  |      |       | V    |
|                                |  | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA, T <sub>J</sub> = 150°C     | 700  |      |       | V    |
| $\Delta BV_{DSS}/\Delta T_{J}$ | Breakdown Voltage Temperature<br>Coefficient | I <sub>D</sub> = 15 mA, Referenced to 25°C                               |      | 0.63 |       | V/°C |
| I <sub>DSS</sub>               | Zero Gate Voltage Drain Current              | V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V                           |      |      | 10    | μΑ   |
|                                |  | V <sub>DS</sub> = 520 V, T <sub>C</sub> = 125°C                          |      | 213  |       |      |
| I <sub>GSS</sub>               | Gate to Body Leakage Current                 | V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V                           |      |      | ±100  | nA   |
| N CHARACTE                     | ERISTICS                                     |  |      |      |       |      |
| V <sub>GS(th)</sub>            | Gate Threshold Voltage                       | $V_{GS} = V_{DS}$ , $I_D = 2.1$ mA                                       | 3.0  |      | 5.0   | V    |
| R <sub>DS(on)</sub>            | Static Drain to Source On Resistance         | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 32.5 A                          |      | 32   | 40    | mΩ   |
| 9FS                            | Forward Transconductance                     | V <sub>DS</sub> = 20 V, I <sub>D</sub> = 32.5 A                          |      | 48   |       | S    |
| YNAMIC CHA                     | RACTERISTICS                                 |  |      |      |       |      |
| C <sub>iss</sub>               | Input Capacitance                            | V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, f = 1 MHz                |      | 5945 |       | pF   |
| C <sub>oss</sub>               | Output Capacitance                           |  |      | 135  |       | pF   |
| C <sub>oss(eff.)</sub>         | Effective Output Capacitance                 | V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V                    |      | 1367 |       | pF   |
| C <sub>oss(er.)</sub>          | Energy Related Output Capacitance            | V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V                    |      | 245  |       | pF   |
| Q <sub>g(tot)</sub>            | Total Gate Charge at 10V                     | V <sub>DS</sub> = 400 V, I <sub>D</sub> = 32.5 A, V <sub>GS</sub> = 10 V |      | 159  |       | nC   |
| Q <sub>gs</sub>                | Gate to Source Gate Charge                   | (Note 4)   |      | 46   |       | nC   |
| Q <sub>gd</sub>                | Gate to Drain "Miller" Charge                |  |      | 64   |       | nC   |
| ESR                            | Equivalent Series Resistance                 | f = 1 MHz  |      | 1.2  |       | Ω    |
| WITCHING CH                    | IARACTERISTICS                               |  |      |      |       |      |
| t <sub>d(on)</sub>             | Turn-On Delay Time                           | $V_{DD} = 400 \text{ V}, I_D = 32.5 \text{ A},$                          |      | 40   |       | ns   |
| t <sub>r</sub>                 | Turn-On Rise Time                            | $V_{GS} = 10 \text{ V}, R_g = 2.2 \Omega$ (Note 4)                       |      | 32   |       | ns   |
| t <sub>d(off)</sub>            | Turn-Off Delay Time                          |  |      | 102  |       | ns   |
| t <sub>f</sub>                 | Turn-Off Fall Time                           |  |      | 26   |       | ns   |
| OURCE-DRAI                     | N DIODE CHARACTERISTICS                      |  |      |      |       |      |
| I <sub>S</sub>                 | Maximum Continuous Source to Drain           | Diode Forward Current  |      |      | 65    | Α    |
| I <sub>SM</sub>                | Maximum Pulsed Source to Drain Diod          | e Forward Current  |      |      | 162.5 | Α    |
| V <sub>SD</sub>                | Source to Drain Diode Forward<br>Voltage     | V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 32.5 A                          |      |      | 1.3   | ٧    |
| t <sub>rr</sub>                | Reverse Recovery Time                        | V <sub>DD</sub> = 400 V, I <sub>SD</sub> = 32.5 A,                       |      | 160  |       | ns   |
| Q <sub>rr</sub>                | Reverse Recovery Charge                      | dI <sub>F</sub> /dt = 100 A/μs   |      | 874  |       | nC   |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

### TYPICAL PERFORMANCE CHARACTERISTICS

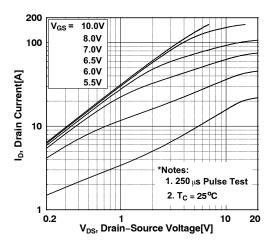


Figure 1. On-Region Characteristics

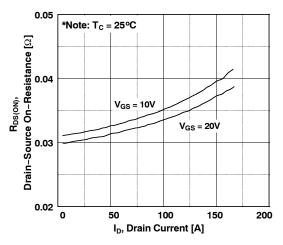


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

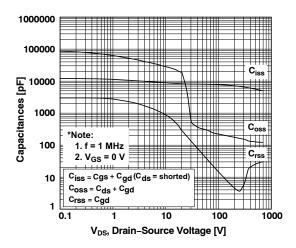


Figure 5. Capacitance Characteristics

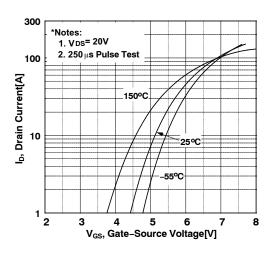


Figure 2. Transfer Characteristics

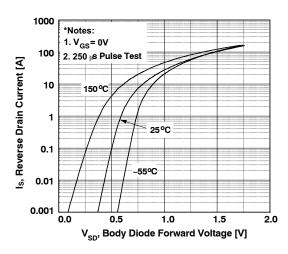


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

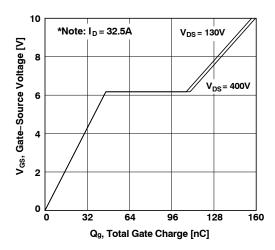


Figure 6. Gate Charge Characteristics

# TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

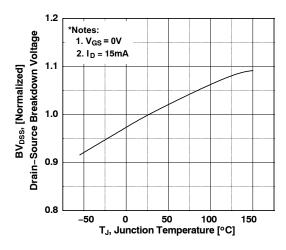


Figure 7. Breakdown Voltage Variation vs. Temperature

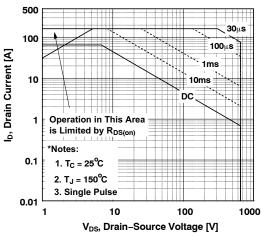


Figure 9. Maximum Safe Operating Area

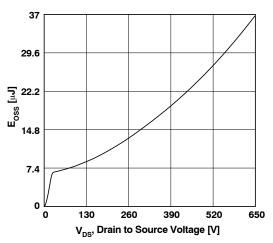


Figure 11. Eoss vs. Drain to Source Voltage

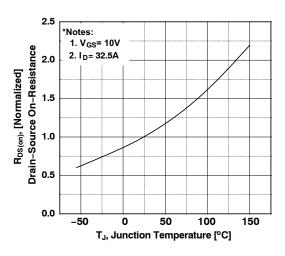


Figure 8. On–Resistance Variation vs. Temperature

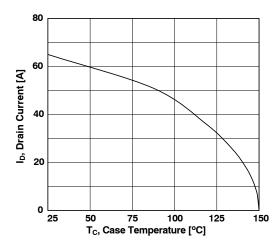


Figure 10. Maximum Drain Current vs. Case Temperature

# TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

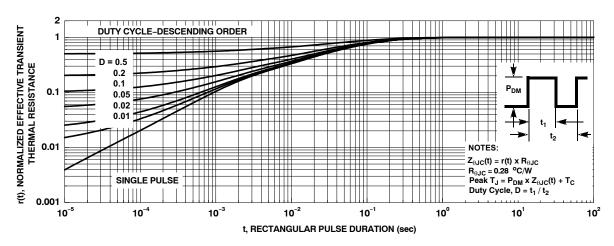


Figure 12. Transient Thermal Response Curve

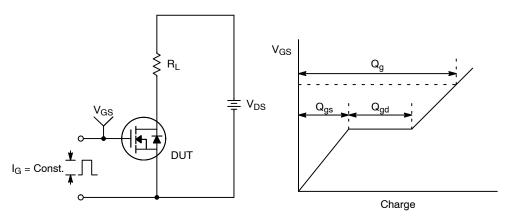


Figure 13. Gate Charge Test Circuit & Waveform

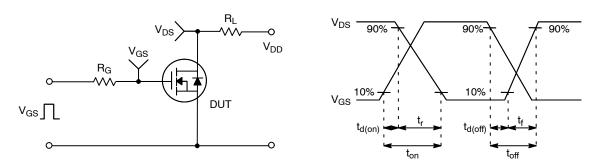


Figure 14. Resistive Switching Test Circuit & Waveforms

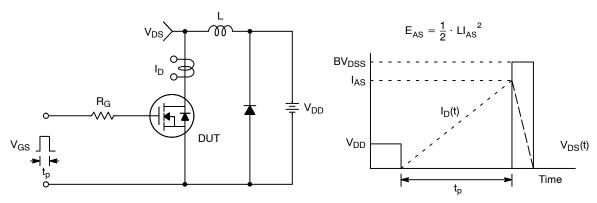


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

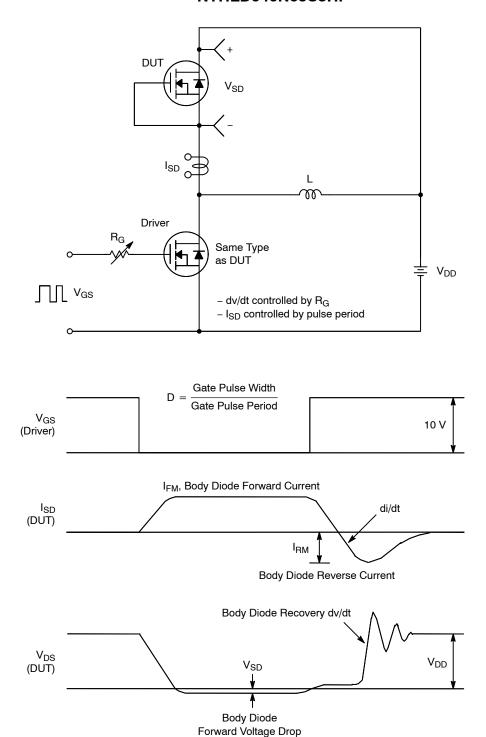
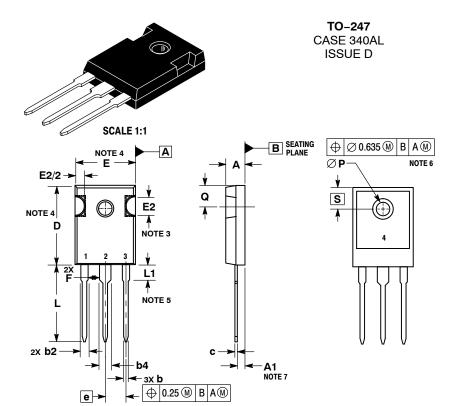


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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**DATE 17 MAR 2017** 

- NOTES:

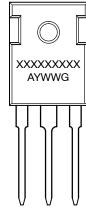
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. SLOT REQUIRED, NOTCH MAY BE ROUNDED.

  - DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH.
    MOLD FLASH SHALL NOT EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREME OF THE PLASTIC BODY
  - LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY
- ©P SHALL HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM DIAMETER OF 3.91.

  DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED

|     | MILLIMETERS |       |  |
|-----|-------------|-------|--|
| DIM | MIN         | MAX   |  |
| Α   | 4.70        | 5.30  |  |
| A1  | 2.20        | 2.60  |  |
| b   | 1.07        | 1.33  |  |
| b2  | 1.65        | 2.35  |  |
| b4  | 2.60        | 3.40  |  |
| С   | 0.45        | 0.68  |  |
| D   | 20.80       | 21.34 |  |
| Е   | 15.50       | 16.25 |  |
| E2  | 4.32        | 5.49  |  |
| е   | 5.45 BSC    |       |  |
| F   | 2.655       |       |  |
| L   | 19.80       | 20.80 |  |
| L1  | 3.81        | 4.32  |  |
| P   | 3.55        | 3.65  |  |
| Q   | 5.40        | 6.20  |  |
| S   | 6.15 BSC    |       |  |

### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code Α = Assembly Location

Υ = Year WW = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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